# MP23AB01DH



# High-performance MEMS audio sensor: fully differential analog bottom-port microphone

Datasheet - production data



#### Features

- Single supply voltage operation
- Fully differential output
- Omnidirectional sensitivity
- High signal-to-noise ratio
- High bandwidth
- Package compliant with reflow soldering
- High RF immunity
- ECOPACK<sup>®</sup>, RoHS, and "Green" compliant

### Description

The MP23AB01DH is a compact, low-power microphone built with a capacitive sensing element and an IC interface.

The sensing element, capable of detecting acoustic waves, is manufactured using a specialized silicon micromachining process to produce audio sensors.

The MP23AB01DH has sensitivity of 38 dB  $\pm$ 1 dB, an acoustic overload point of 135 dBSPL with minimum 65 dB signal-to-noise ratio.

The MP23AB01DH has fully differential output in order to minimize common mode noise.

The MP23AB01DH is available in a package compliant with reflow soldering and is guaranteed to operate over an extended temperature range from -40 °C to +85 °C.

#### Table 1: Device summary

Order code	Temp. range (°C)	Package	Packing
MP23AB01DH	-40 to +85	(3.35 x 2.5 x 0.98) mm	Tray
MP23AB01DHTR	-40 to +85	(3.35 x 2.5 x 0.98) mm	Tape and reel

DocID030017 Rev 1

This is information on a product in full production.

#### Contents

Con	tents		
1	Pin desc	ription	3
2	Acoustic	and electrical specifications	4
	2.1	Acoustic and electrical characteristics	4
	2.2	Frequency response	5
3	Absolute	e maximum ratings	6
4	Applicat	ion recommendations	7
	4.1	MP23AB01DH schematic hints	7
5	Package	information	8
	5.1	Soldering information	8
	5.2	RHLGA 4-lead package information	9
6	Reliabilit	ty tests	10
7	Revision	history	11



# 1 Pin description



#### Table 2: Pin description

Pin number	Pin name	Function
1	Vdd	Power supply
2	Output–	Negative output signal
3	Output+	Positive output signal
4	Ground	Ground



#### 2 Acoustic and electrical specifications

#### 2.1 Acoustic and electrical characteristics

The values listed in the table below are specified for Vdd = 2.7 V, No Load, Tamb = 25 °C unless otherwise specified.

Symbol	Parameter	Test condition	Min.	Typ. <sup>(1)</sup>	Max.	Unit
-				••		
Vdd	Supply voltage		2.3	2.7	3.6	V
ldd	Current consumption				250	μA
So	Sensitivity	@1 kHz (0 dB = 1 V/Pa)	-39	-38	-37	dBV
SNR	Signal-to-noise ratio	A-weighted (20 Hz - 20 kHz)	65			dB(A)
PSR	Power supply rejection	100 mVpp sine wave @217 Hz		-100		dB
AOP	Acoustic overload point			135		dBSPL
Zout	Output impedance				400	Ω
Cload	Load capacitance				150	рF
Rload	Load resistance		30			κΩ
Тор	Operating temperature range		-40		+85	°C

**Table 3: Acoustic and electrical characteristics** 

#### Notes:

<sup>(1)</sup>Typical specifications are not guaranteed.

Table 4. Typical distortion specifications at TKHZ sine wave input		
Parameter Test condition Typ. value		Typ. value
THD+N	94 dBSPL	< 0.2%
	110 dBSPL	< 0.5%
	120 dBSPL	< 3%
	130 dBSPL	< 5%

#### Table 4: Typical distortion specifications at 1 kHz sine wave input

## 2.2 Frequency response





#### Absolute maximum ratings 3

Stresses above those listed as "Absolute maximum ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device under these conditions is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

Symbol	Ratings	Maximum value	Unit
Vdd	Supply voltage	-0.5 to 4.8	V
T <sub>STG</sub>	Storage temperature range	-40 to +105	°C
ESD	(HBM) ANSI/ESDA/JEDEC JS001	±2000	V
ESD	(MM) EIA/JESD22-A115	±200	V
ESD	(CDM) JESD22-C101	±750	V
ESD (1)	Per IEC61000-4-2, 3 discharges, 150 pF, 330 $\Omega$ direct contact to housing. MIC must be at zero potential before each discharge.	±8000	V

Table	5.	Absolute	maximum	ratings
Iable	J.	ADSOIULE	maximum	raunyə

#### Notes:

<sup>(1)</sup>Bypass capacitor 200 nF or 1 µF (better), is definitely recommended for ESD main clamp integrity.

This device is sensitive to mechanical shock, improper handling can cause permanent damage to the part.



X)

This device is sensitive to electrostatic discharge (ESD), improper handling can cause permanent damage to the part.



# 4 Application recommendations

### 4.1 MP23AB01DH schematic hints

Figure 3: MP23AB01DH electrical connections and external component values





# 5 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK<sup>®</sup> is an ST trademark.

### 5.1 Soldering information



Table 6: Recommended soldering profile limits			
Description	Parameter	Pb free	
Average ramp rate	$T_L$ to $T_P$	3 °C/sec max	
Preheat Minimum temperature Maximum temperature Time (T <sub>SMIN</sub> to T <sub>SMAX</sub> )	Т <sub>SMIN</sub> Tsmax ts	150 °C 200 °C 60 sec to 120 sec	
Ramp-up rate	$T_{\text{SMAX}}$ to $T_{\text{L}}$		
Time maintained above liquidus temperature Liquidus temperature	t∟ T∟	60 sec to 150 sec 217 °C	
Peak temperature	Τ <sub>Ρ</sub>	260 °C max	
Time within 5 °C of actual peak temperature		20 sec to 40 sec	
Ramp-down rate		6 °C/sec max	
Time 25 °C (t = 25 °C) to peak temperature		8 minutes max	



# 5.2 RHLGA 4-lead package information







# 6 Reliability tests

The device passed all reliability tests on three different assembly lots under the following conditions in the table below.

Test name	Description	Conditions
	The device is stressed in dynamic configuration, approaching the operative	Vdd(max) = 3.6 V;
HTOL: High Temperature Operating Life	max. absolute ratings in terms of junction temperature, load current, internal	Tamb = 125 °C
	power dissipation.	JESD22a108
	The device is stored in an unbiased condition at the maximum temperature	Ta = 125 °C
HTS: High Temperature Storage	allowed by the package materials, sometimes higher than the maximum operative temperature.	JESD22a103
<b>PC (JL3):</b> Preconditioning (solder simulation)	The device is submitted to a typical temperature profile used for surface mounting, after controlled moisture absorption	
	The device is submitted to cycled temperature excursions, between a hot	Ta Cycling: -40 °C ±125°C
TC: Temperature Cycling	and a cold chamber in air atmosphere	JESD22a104
ESD (HBM): Electrostatic		Voltage ±2000 V
Discharge (Human Body Model)		JEDEC / JESD22-A114E
ESD (MM): Electrostatic Discharge		Voltage +/-200V
(Machine Model)	The device is submitted to a high voltage peak on all his pins simulating ESD stress according to different simulation models.	JEDEC/JESD-A115-A
ESD (CDM): Electrostatic		Voltage ±750 V
Discharge (Charged Device Model)		ANSI / ESD STM 5.3.1 ESDA
	The device is submitted to a direct surrout force d/such into the imput/submit	Current injection ±200 mA
LU (CI): Latch-up (Overvoltage and Current Injection)	The device is submitted to a direct current forced/sunk into the input/output pins. Removing the direct current, no change in the supply current must be	Overvoltage 1.5 x Vmax
	observed.	EIA/JESD78
	The device is blocked in static configuration within the interval states	Vdd(nom) = 2.7 V
THB: Temperature Humidity Bias	The device is biased in static configuration minimizing its internal power dissipation, and stored at controlled conditions for ambient temperature and	T = 85 ° C / RH = 85%
	relative humidity.	JESD22a108
	The device is stored in an unbiased condition at the min. temperature	Ta = -40°C
LTS: Low Temperature Storage	allowed by the package materials, sometimes lower than the min. op. temp	JESD22a119
		10000 g / 0.1 ms
MS: Mechanical Shock	The device is submitted to 10000 g / 0.1 ms	5 shocks for each axis, under bias
	5 shocks for each axis.	MIL STD 883MIL

Table 7: Tests and	summary of results
--------------------	--------------------



# 7 Revision history

Table 8: I	Document	revision	historv
------------	----------	----------	---------

Date	Revision	Changes
17-Nov-2016	1	Initial release



#### IMPORTANT NOTICE – PLEASE READ CAREFULLY

STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice. Purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST's terms and conditions of sale in place at the time of order acknowledgement.

Purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of Purchasers' products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

ST and the ST logo are trademarks of ST. All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.

© 2016 STMicroelectronics - All rights reserved

